

<b>Notice of References Cited</b>	Application/Control No. 10/697,021		Applicant(s)/Patent Under Reexamination YONETANI ET AL.	
	Examiner Sang Nguyen		Art Unit 2877	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,917,377	07-2005	Aizaki et al.	348/79
*	B	US-6,674,574	01-2004	Aono, Yasushi	359/383
*	C	US-6,608,314	08-2003	Hayashi, Shinichi	250/458.1
*	D	US-6,594,075	07-2003	Kanao et al.	359/385
*	E	US-6,496,308	12-2002	Yonetani et al.	359/434
*	F	US-6,384,967	05-2002	Watanabe et al.	359/385
*	G	US-5,896,224	04-1999	Kapitza, Hans-G.	359/389
*	H	US-5,710,663	01-1998	Kawasaki, Kenji	359/389
*	I	US-4,643,540	02-1987	Kawasaki et al.	359/368
*	J	US-4,013,347	03-1977	Nakamura, Akiyoshi	359/707
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.